

**Search Notes**

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Examiner

Ahmed M. Farah

Applicant(s)/Patent under  
Reexamination

FUJIEDA, MASANAO

Art Unit

3735

**SEARCHED**

Class	Subclass	Date	Examiner
606	4-6,10-12	6/12/2006	AF
351	208-212	6/12/2006	AF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search Histor Printout		6/12/2006	AF

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search; and EAST search: Classification (IS&R); and Text (BRS)	6/12/2006	AF
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	6/12/2006	AF
See the attached "Search History."	6/12/2006	AF